

54AC11020, 74AC11020 DUAL 4-INPUT POSITIVE-NAND GATES

D2957, MARCH 1987 – REVISED APRIL 1993

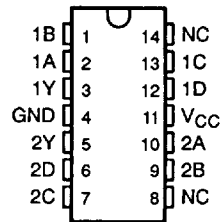
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- EPIC™ (Enhanced-Performance Implanted CMOS) 1- μ m Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

description

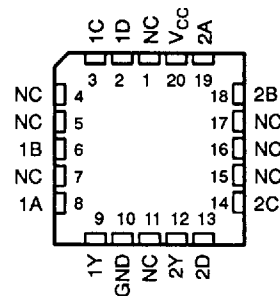
These devices contain two independent 4-input NAND gates. They perform the Boolean functions $Y = \overline{A \cdot B \cdot C \cdot D}$ or $Y = \overline{\overline{A} + \overline{B} + \overline{C} + \overline{D}}$ in positive logic.

The 54AC11020 is characterized for operation over the full military temperature range of -55°C to 125°C . The 74AC11020 is characterized for operation from -40°C to 85°C .

54AC11020 . . . J PACKAGE
74AC11020 . . . D OR N PACKAGE
(TOP VIEW)



54AC11020 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

FUNCTION TABLE
(each gate)

INPUTS				OUTPUT
A	B	C	D	Y
H	H	H	H	L
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H

EPIC is a trademark of Texas Instruments Incorporated.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

TEXAS
INSTRUMENTS

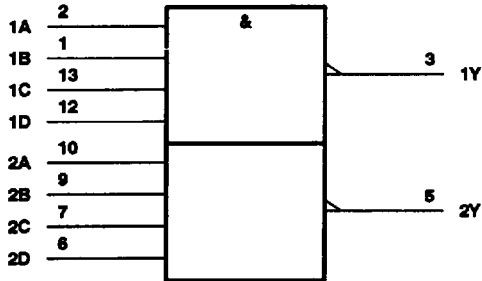
POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

Copyright © 1993, Texas Instruments Incorporated

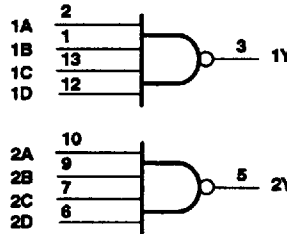
54AC11020, 74AC11020 DUAL 4-INPUT POSITIVE-NAND GATES

D2957, MARCH 1967 - REVISED APRIL 1963

logic symbol†



logic diagram (positive logic)



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V_{CC}	-0.5 V to 7 V
Input voltage range, V_I (see Note 1)	-0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Note 1)	-0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	± 20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	± 50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	± 50 mA
Continuous current through V_{CC} or GND	± 100 mA
Storage temperature range	-65°C to 150°C

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

8961723 0094286 184

TEXAS
INSTRUMENTS

POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

54AC11020, 74AC11020 DUAL 4-INPUT POSITIVE-NAND GATES

D2957, MARCH 1987—REVISED MARCH 1990

recommended operating conditions

		54AC11020			74AC11020			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage	3	5	5.5	3	5	5.5	V
V _{IH}	High-level input voltage	V _{CC} = 3 V		2.1	2.1		V	
		V _{CC} = 4.5 V		3.15	3.15			
		V _{CC} = 5.5 V		3.85	3.85			
V _{IL}	Low-level input voltage	V _{CC} = 3 V			0.9	0.9	V	
		V _{CC} = 4.5 V			1.35	1.35		
		V _{CC} = 5.5 V			1.65	1.65		
V _I	Input voltage	0	V _{CC}		0	V _{CC}		V
V _O	Output voltage	0	V _{CC}		0	V _{CC}		V
I _{OH}	High-level output current	V _{CC} = 3 V			-4	-4	mA	
		V _{CC} = 4.5 V			-24	-24		
		V _{CC} = 5.5 V			-24	-24		
I _{OL}	Low-level output current	V _{CC} = 3 V			12	12	mA	
		V _{CC} = 4.5 V			24	24		
		V _{CC} = 5.5 V			24	24		
Δt/Δv	Input transition rise or fall rate	0	10		0	10		ns/V
T _A	Operating free-air temperature	-55	125		-40	85		°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C			54AC11020		74AC11020		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V _{OH}	I _{OH} = -50 μA	3 V	2.9			2.9	2.9	V		
		4.5 V	4.4			4.4	4.4			
		5.5 V	5.4			5.4	5.4			
	I _{OH} = -4 mA	3 V	2.58			2.4	2.48			
		4.5 V	3.94			3.7	3.8			
	I _{OH} = -24 mA	5.5 V	4.94			4.7	4.8			
		5.5 V				3.85				
V _{OL}	I _{OL} = 50 μA	3 V		0.1		0.1	0.1	V		
		4.5 V		0.1		0.1	0.1			
		5.5 V		0.1		0.1	0.1			
	I _{OL} = 12 mA	3 V		0.36		0.5	0.44			
		4.5 V		0.36		0.5	0.44			
	I _{OL} = 24 mA	5.5 V		0.36		0.5	0.44			
		5.5 V				1.65				
I _{OL} = 50 mA†	5.5 V									
	5.5 V					1.65				
I _I	V _I = V _{CC} or GND	5.5 V		±0.1		±1	±1	μA		
I _{CC}	V _I = V _{CC} or GND, I _O = 0	5.5 V		4		80	40	μA		
C _I	V _I = V _{CC} or GND	5 V		3.5				pF		

† Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

8961723 0094287 010

TEXAS
INSTRUMENTS

POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

2-61

54AC11020, 74AC11020 DUAL 4-INPUT POSITIVE-NAND GATES

D2957, MARCH 1987 - REVISED APRIL 1993

switching characteristics over recommended operating free-air temperature range,
 $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$T_A = 25^\circ\text{C}$			54AC11020		74AC11020		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	1.5	6.4	8.6	1.5	10	1.5	9.4	ns
t_{PHL}			1.5	6.4	9.2	1.5	10.7	1.5	10.1	

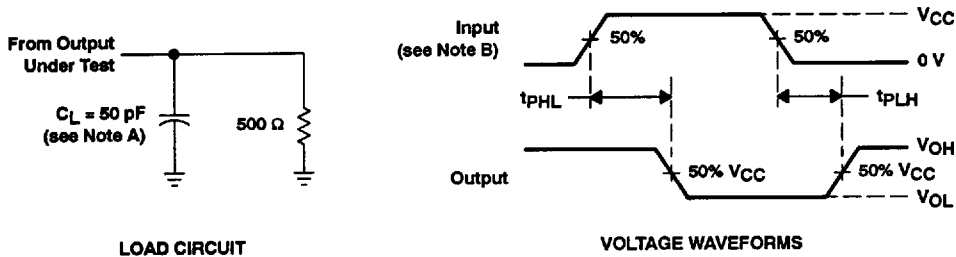
switching characteristics over recommended operating free-air temperature range,
 $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$T_A = 25^\circ\text{C}$			54AC11020		74AC11020		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	Any	Y	1.5	4.3	8.1	1.5	7	1.5	6.7	ns
t_{PHL}			1.5	4.4	7.8	1.5	7.7	1.5	7.3	

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C_{pd} Power dissipation capacitance per gate	$C_L = 50 \text{ pF}$, $f = 1 \text{ MHz}$	19	pF

PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and jig capacitance.
 B. Input pulses are supplied by generators having the following characteristics: $PRR \leq 10 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r = 3 \text{ ns}$, $t_f = 3 \text{ ns}$.
 C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

8961723 0094288 T57

TEXAS
INSTRUMENTS

POST OFFICE BOX 655303 • DALLAS, TEXAS 75265